

2N7639-GA

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600 V

Normally – OFF Silicon Carbide Junction Transistor

Features

- 250 °C maximum operating temperature
- Temperature independent switching performance
- Electrically isolated base-plate
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- · Low gate charge
- Low intrinsic capacitance

Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- · High short circuit withstand capability

$V_{DS(ON)} = 1.3 V$ $I_D = 20 A$ $R_{DS(ON)} = 65 m\Omega$

=

V_{DS}

Package



TO - 257 (Isolated Base-plate Hermetic Package)

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings at T_i = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V _{DS}	$V_{GS} = 0 V$	600	V
Continuous Drain Current	I _D	145 °C < T _C < 160 °C	20	А
Gate Peak Current	I _{GM}		5	А
Turn-Off Safe Operating Area	RBSOA	T_{VJ} = 250 °C, I_G = 1 A, Clamped Inductive Load	I _{D,max} = 20 @ V _{DS} ≤ V _{DSmax}	А
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 250 °C, I_G = 2.5 A, V_{DS} = 400 V, Non Repetitive	20	μs
Reverse Gate – Source Voltage	V _{GS}	·	30	V
Reverse Drain – Source Voltage	V _{DS}		40	V
Power Dissipation	P _{tot}	T _C = 25 °C	22	W
Operating and Storage Temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Devemeter	Sympol	Symbol Conditions –	Values		11	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
On Characteristics						
Drain – Source On Voltage	V _{DS(ON)}	$\begin{array}{l} I_{\rm D} = 20 \text{ A}, \ I_{\rm G} = 400 \text{ mA}, \ T_{\rm J} = 25 \ ^{\circ}\text{C} \\ I_{\rm D} = 20 \text{ A}, \ I_{\rm G} = 500 \text{ mA}, \ T_{\rm J} = 125 \ ^{\circ}\text{C} \\ I_{\rm D} = 20 \text{ A}, \ I_{\rm G} = 1000 \text{ mA}, \ T_{\rm J} = 175 \ ^{\circ}\text{C} \\ I_{\rm D} = 20 \text{ A}, \ I_{\rm G} = 1000 \text{ mA}, \ T_{\rm J} = 250 \ ^{\circ}\text{C} \end{array}$		1.3 1.8 2.2 3.3		V
Drain – Source On Resistance	R _{DS(ON)}	$ \begin{array}{l} I_{D} = 20 \text{ A}, \text{ I}_{G} = 400 \text{ mA}, \text{ T}_{J} = 25 \ ^{\circ}\text{C} \\ I_{D} = 20 \text{ A}, \text{ I}_{G} = 500 \text{ mA}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ I_{D} = 20 \text{ A}, \text{ I}_{G} = 1000 \text{ mA}, \text{ T}_{J} = 175 \ ^{\circ}\text{C} \\ I_{D} = 20 \text{ A}, \text{ I}_{G} = 1000 \text{ mA}, \text{ T}_{J} = 250 \ ^{\circ}\text{C} \end{array} $		65 91 110 165		mΩ
Gate Forward Voltage	$V_{GS(FWD)}$	I _G = 1000 mA, T _j = 25 °C I _G = 1000 mA, T _j = 250 °C		3.0 2.7		V
DC Current Gain	β	$ \begin{array}{l} V_{DS} = 5 \mbox{ V, } I_D = 20 \mbox{ A, } T_j = 25 \mbox{ °C} \\ V_{DS} = 5 \mbox{ V, } I_D = 20 \mbox{ A, } T_j = 125 \mbox{ °C} \\ V_{DS} = 5 \mbox{ V, } I_D = 20 \mbox{ A, } T_j = 175 \mbox{ °C} \\ V_{DS} = 5 \mbox{ V, } I_D = 20 \mbox{ A, } T_j = 250 \mbox{ °C} \end{array} $		110 78 73 69		



Off Characteristics

Drain Leakage Current	I _{DSS}	V _R = 600 V, V _{GS} = 0 V, T _j = 25 °C V _R = 600 V, V _{GS} = 0 V, T _i = 175 °C	10 50	μA
5	500	$V_{R} = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_{j} = 250 \text{ °C}$	100	
Gate Leakage Current	I _{SG}	V _{SG} = 20 V, T _j = 25 °C	20	nA

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

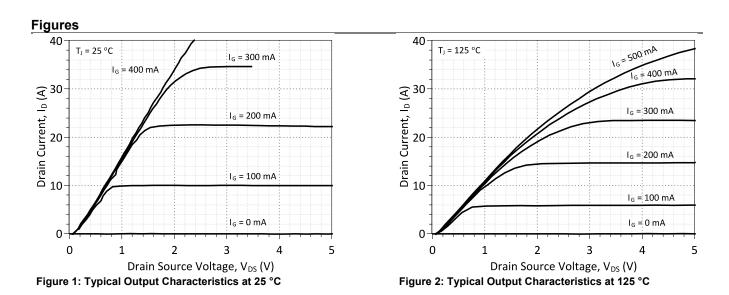
Parameter	Symbol	Symbol Conditions	Values			11014
	Symbol	Conditions	min.	typ.	max.	Unit
Capacitance Characteristics						
Gate-Source Capacitance	C _{gs}	V _{GS} = 0 V, f = 1 MHz		2400		pF
Input Capacitance	Ciss	V_{GS} = 0 V, V_{D} = 1 V, f = 1 MHz		3700		pF
Reverse Transfer/Output Capacitance	C_{rss}/C_{oss}	V _D = 1 V, f = 1 MHz		840		pF

Switching Characteristics

Turn On Delay Time	t _{d(on)}	$V_{DD} = 400 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = -8/15 \text{ V}, T_j = 175 \text{ °C}$ Refer to Figure 15 for gate drive current waveforms	92	ns
Rise Time	tr		42	ns
Turn Off Delay Time	t _{d(off)}		51	ns
Fall Time	t _f		31	ns
Furn-On Energy Per Pulse	Eon		811	μJ
Turn-Off Energy Per Pulse	E _{off}		96	μJ
Total Switching Energy	E _{ts}		907	μJ
Turn On Delay Time	t _{d(on)}		91	ns
Rise Time	tr	1	17	ns
Turn Off Delay Time	t _{d(off)}	$V_{DD} = 400 \text{ V}, I_D = 20 \text{ A},$	50	ns
Fall Time	t _f	V_{GS} = -8/15 V ,T _j = 250 °C Refer to Figure 15 for gate drive	21	ns
Turn-On Energy Per Pulse	Eon	current waveforms	100	μJ
Turn-Off Energy Per Pulse	E _{off}		40	μJ
Total Switching Energy	E _{ts}	Τ Γ	140	μJ

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	1.16	°C/W



2N7639-GA

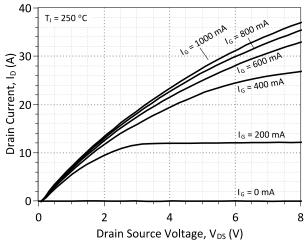


Figure 3: Typical Output Characteristics at 250 °C

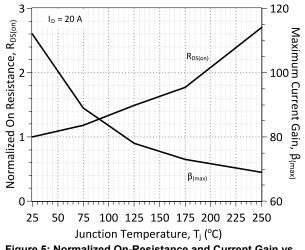
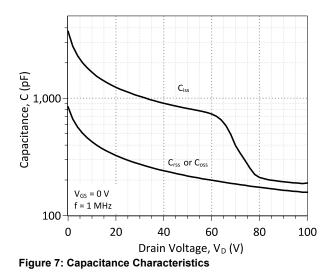


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature



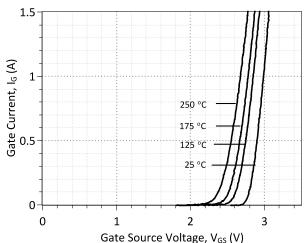


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

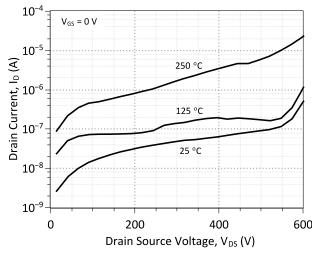
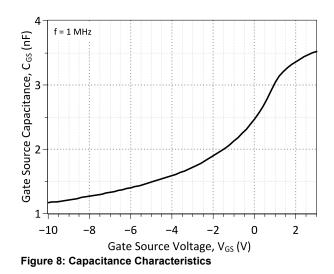


Figure 6: Typical Blocking Characteristics



GeneSiC SEMICONDUCTOR

2N7639-GA

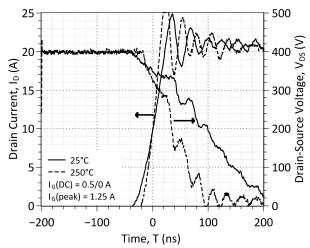
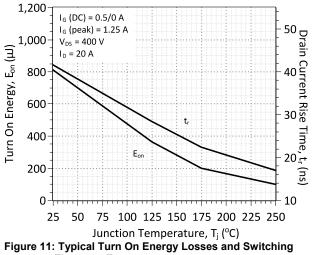
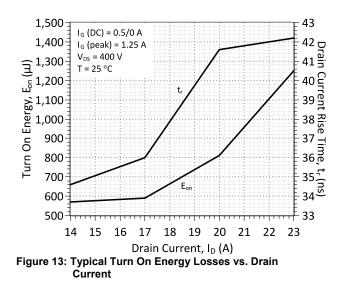


Figure 9: Typical Hard-switched Turn On Waveforms







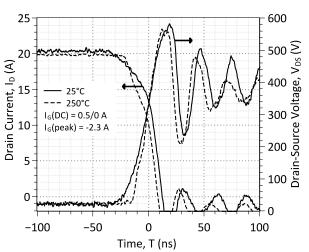
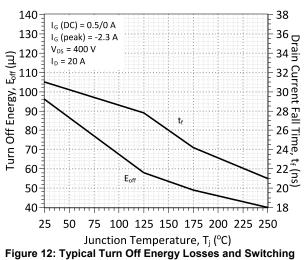
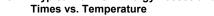
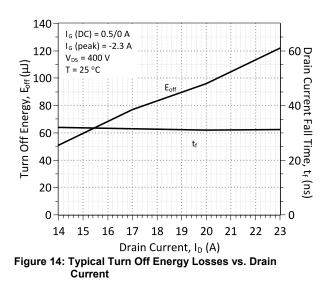


Figure 10: Typical Hard-switched Turn Off Waveforms







2N7639-GA

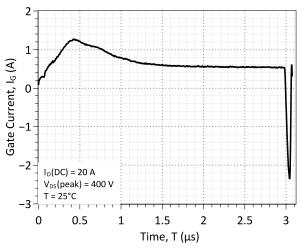
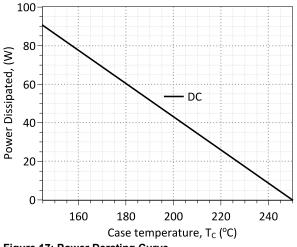
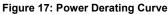
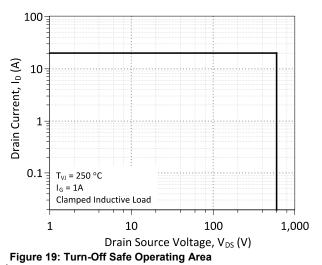


Figure 15: Typical Gate Current Waveform







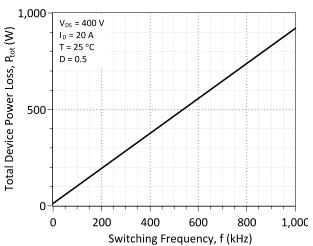
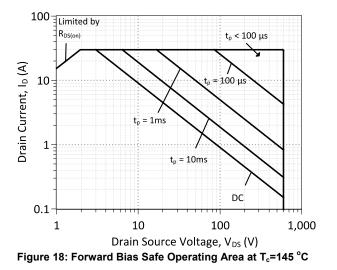
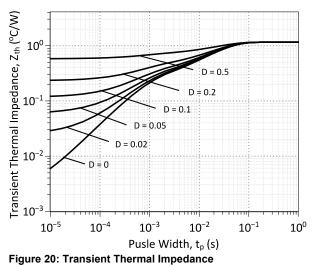


Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency ¹





¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.



Gate Drive Technique (Option #1)

To drive the 2N7639-GA with the lowest gate drive losses, please refer to the dual voltage source gate drive configuration described in Application Note AN-10B (http://www.genesicsemi.com/index.php/references/notes).

Gate Drive Technique (Option #2)

The 2N7639-GA can be effectively driven using the IXYS IXDN614 / IXDD614 non-inverting gate driver IC or a comparable product. A typical gate driver configuration along with component values using this driver is offered below. Additional information is available in GeneSiC Application Note AN-10A and from the manufacturer at www.ixys.com.

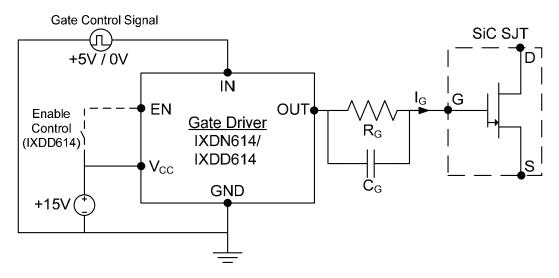


Figure 21: Recommended Gate Diver Configuration (Option #2)

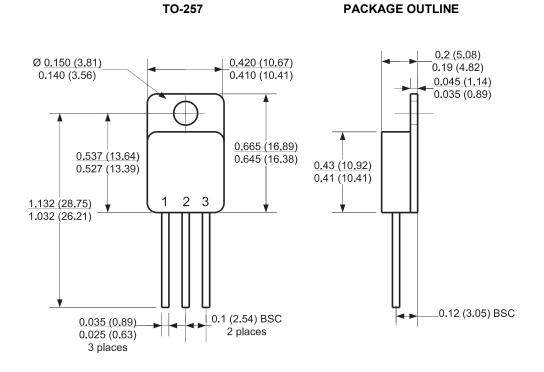
Parameter	Symbol	Conditions	Values			Unit
	Symbol	Conditions	min.	typ.	max.	Unit
Option #1 Gate Drive Conditions (IX	DD614/IXDN614)					
Supply Voltage, High Side Driver	V _{cc}	V _{GH}	15	20	30	V
Supply Voltage, Low Side Driver	V _{cc}	V _{GL}	5	6.5		V
Off State Voltage, Both Drivers	GND	V _{EE}		-10	0	V
Gate Control Input Signal, Low	IN		-5.0	0	0.8	V
Gate Control Input Signal, High	IN		4	5.0	V _{CC} +0.3	V
Enable, Low	EN	IXDD614 Only			1/3*V _{CC}	V
Enable, High	EN	IXDD614 Only	2/3*V _{CC}			V
Output Voltage, Low	V _{OUT}				0.025	V
Output Voltage, High	V _{OUT}		V _{CC} -0.025			V
Output Current, Peak	lout	Package Limited			14	А
Output Current, Continuous	I _{OUT}			0.5	4.0	А

Passive Gate Components

Gate Resistance	R _G	V_{GL} = 6.0 V, $I_G \approx 0.5$ A		1.6	5	Ω
Gate Capacitance	C _G	V_{GH} = 20 V, $I_{G,pk} \approx 4.0$ A	20	35		nF



Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date	Revision	Comments	Supersedes			
2013/12/09	2	Updated Electrical Characteristics				
2013/11/18	1	Updated Electrical Characteristics				
2012/08/24	0	Initial release				

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 2N7639-GA device.

```
*
     MODEL OF GeneSiC Semiconductor Inc.
*
*
     $Revision: 1.0
                                $
*
     $Date: 06-SEP-2013
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*
*
    GeneSiC Semiconductor Inc.
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* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
.model 2N7639-GA NPN
+ IS
       6.03E-47
+ ISE
          1.72E-28
+ EG
          3.23
+ BF
          122
+ BR
         0.55
         300
+ IKF
+ NF
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         1.868
+ NE
+ RB
         0.26
+ RE
         0.088
         0.01
+ RC
         5.68E-10
+ CJC
+ VJC
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+ MJC
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+ CJE
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+ VJE
         2.77859888
+ MJE
         0.48415
+ XTI
         3
          -0.78
+ XTB
          7.00E-02
+ TRC1
+ VCEO
         600
+ ICRATING 20
+ MFG GeneSiC Semiconductor
* End of 2N7639-GA SPICE Model
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